

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No	09/755,673
Confirmation No	
Filing Date	January 5, 200
Inventor	Leonard Forbes, et al
Assignee	Micron Technology, Inc
Group Art Unit	282
Examiner	Nguyen, K.D
Attorney's Docket No	Ml22-153
Customer No	021567
Title: Methods of Forming Canacitor Structures	

To: Mail Stop RCE

Commissioner for Patents

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SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Reference -- See Attached Form PTO-1449

This Request for Continued Examination (RCE) Application is being filed in an abundance of caution to ensure consideration of the references listed on the attached form PTO-1449. Pursuant to Federal Register Vol. 69, No. 182, pg. 56542 (September 21, 2004), no copies of the cited U.S. patents are included herewith.

The attached form PTO-1449 is submitted in compliance with 37 CFR §1.56. No admission is made regarding whether the submitted references are prior art.

Respectfully submitted,

By:

Robert C. Hyta Reg. No. 46,791 Form PTO-1449

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE



ATTY. DOCKET NO. MI22-1531

SERIAL NO. 09/755,573

APPLICANT Leonard Forbes et al.

FILING DATE January 5, 2001

GROUP 2823

U.S. PATENT DOCUMENTS

			U.S.	PATENT DOCUMENTS				
Examiner Initial		Document Number	Date	Name	Class	Subclass		ng Date propriate
	AA	5,739,563 A1	04/98	Kawakubo et al	257	295		
	AB	5,774,327 A1	06/98	Park, Soon-oh	361	321.5		
	AC	6,103,565 A1	08/00	Green et al.	438	238		_
	AD	6,103,567	08/00	Shih et al.	438	251		
	AE	6,187,824 B1	02/01	Huang, Jenn Ming	438	253		
	AF							
	AG							
	AH							
	AI	, , , , ,						
	AJ							
-			FOREI	GN PATENT DOCUMENTS	.	<u> </u>		
		Document Number	Date	Country	Class	Sub- class	Translation Yes No	
	AK							
	AL							
	AM							_
		OTHER REFE	RENCES (ir	ncluding Author, Title, Date, Pertin	ent Pages	s, Etc.)		
_	AN							
	AO							
	AP							
EXAMIN	ER	DATE CONSIL	DERED					

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.